e·MMC™ Memory

MTFC4GMVEA-4M IT, MTFC8GLVEA-4M IT, MTFC16GJVEC-4M IT, MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT

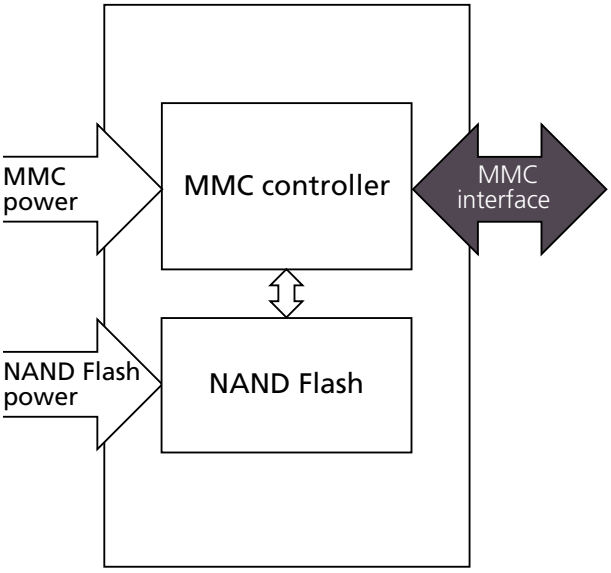
Features

- MultiMediaCard (MMC) controller and NAND Flash
- 153- or 169-ball WFBGA/VFBGA/LFBGA (RoHS 6/6-compliant)
- V_{CC}: 2.7–3.6V
- V_{CCQ} (dual voltage): 1.65–1.95V; 2.7–3.6V
- Temperature ranges
  - Industrial temperature: –40˚C to +85˚C
  - Storage temperature: –40˚C to +85˚C
- Typical current consumption
  - Standby current: 120µA for 4GB–16GB; 140µA for 32GB; 160µA for 64GB
  - Active current (RMS): 80mA (4GB–64GB)

MMC-Specific Features

- JEDEC/MMC standard version 4.41-compliant (JEDEC Standard No. 84-A441) – SPI mode not supported (see www.jedec.org/sites/default/files/docs/JESD84-A441.pdf)
  - Advanced 11-signal interface
  - x1, x4, and x8 I/Os, selectable by host
  - MMC mode operation
  - Command classes: class 0 (basic); class 2 (block read); class 4 (block write); class 5 (erase); class 6 (write protection); class 7 (lock card)
  - MMC*plus*™ and MMC*mobile*™ protocols
  - Temporary write protection
  - 52 MHz clock speed (MAX)
  - Boot operation (high-speed boot)
  - Sleep mode
  - Replay-protected memory block (RPMB)
  - Secure erase and trim
  - Hardware reset signal
  - Multiple partitions with enhanced attribute
  - Permanent and power-on write protection
  - Double data rate (DDR) function
  - High-priority interrupt (HPI)

Figure 1: Micron *e*·MMC Device



MMC-Specific Features (Continued)

- Enhanced reliable write
- Configurable reliability settings
- Background operation
- Fully enhanced configurable
- Backward-compatible with previous MMC modes

- ECC and block management implemented

e·MMC Performance

Table 1: MLC Partition Performance

Condition	Part Number		Units
	MTFC4GMVEA-4M IT MTFC8GLVEA-4M IT	MTFC16GJVEC-4M IT MTFC32GJVED-4M IT MTFC64GJVDN-4M IT	
Sequential write	13.5	20	MB/s
Sequential read	44	44	MB/s

Note: 1. Sequential access of 1MB chunk. Additional performance data, such as power consumption or timing for different device modes, will be provided in a separate document upon customer request.

Ordering Information

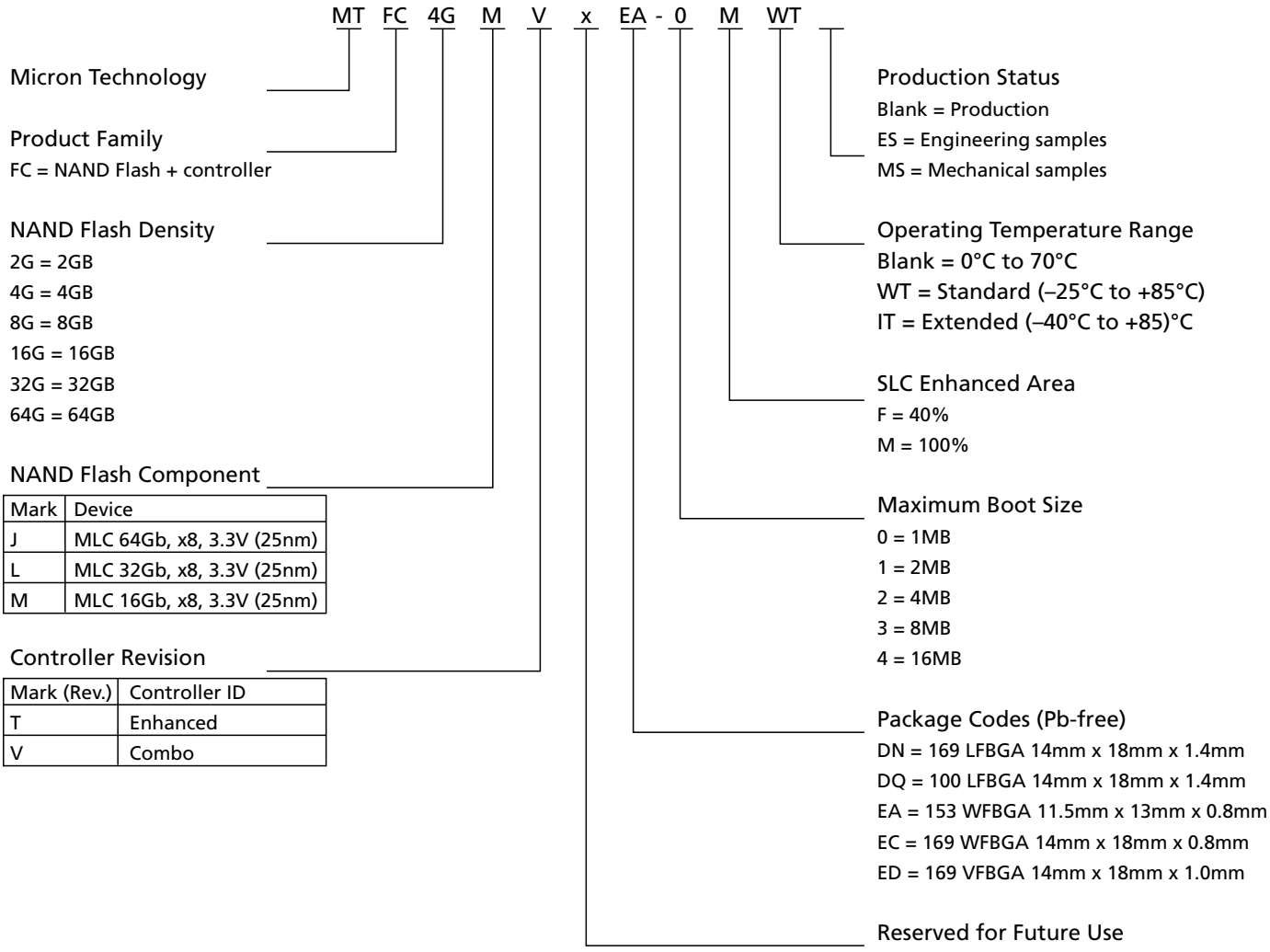
Table 2: Ordering Information

Base Part Number	Density	Package	NAND Flash Type	Shipping Media
MTFC4GMVEA-4M IT	4GB	153-ball WFBGA 11.5mm x 13.0mm x 0.8mm	2 x 16Gb, MLC, 25nm	Tray
				Tape and reel
MTFC8GLVEA-4M IT	8GB	153-ball WFBGA 11.5mm x 13.0mm x 0.8mm	2 x 32Gb, MLC, 25nm	Tray
				Tape and reel
MTFC16GJVEC-4M IT	16GB	169-ball WFBGA 14.0mm x 18.0mm x 0.8mm	2 x 64Gb, MLC, 25nm	Tray
				Tape and reel
MTFC32GJVED-4M IT	32GB	169-ball VFBGA 14.0mm x 18.0mm x 1.0mm	4 x 64Gb, MLC, 25nm	Tray
				Tape and reel
MTFC64GJVDN-4M IT	64GB	169-ball LFBGA 14.0mm x 18.0mm x 1.4mm	8 x 64Gb, MLC, 25nm	Tray
				Tape and reel

Part Numbering Information

Micron®*e*·MMC memory devices are available in different configurations and densities. Verify valid part numbers by using Micron's part catalog search at www.micron.com. To compare features and specifications by device type, visit www.micron.com/products. Contact the factory for devices not found.

Figure 2: Marketing Part Number Chart



Mark	Device
J	MLC 64Gb, x8, 3.3V (25nm)
L	MLC 32Gb, x8, 3.3V (25nm)
M	MLC 16Gb, x8, 3.3V (25nm)

Mark (Rev.)	Controller ID
T	Enhanced
V	Combo

Note: 1. Not all combinations are necessarily available. For a list of available devices or for further information on any aspect of these products, please contact your nearest Micron sales office.

General Description

Micron *e*·MMC is a communication and mass data storage device that includes a MultiMediaCard (MMC) interface, a NAND Flash component, and a controller on an advanced 11-signal bus, which is compliant with the MMC system specification. Its cost per bit, small package sizes, and high reliability make it an ideal choice for industrial applications like infrastructure and networking equipment, PC and servers, a variety of other industrial products.

The nonvolatile *e*·MMC draws no power to maintain stored data, delivers high performance across a wide range of operating temperatures, and resists shock and vibration disruption.

Signal Descriptions

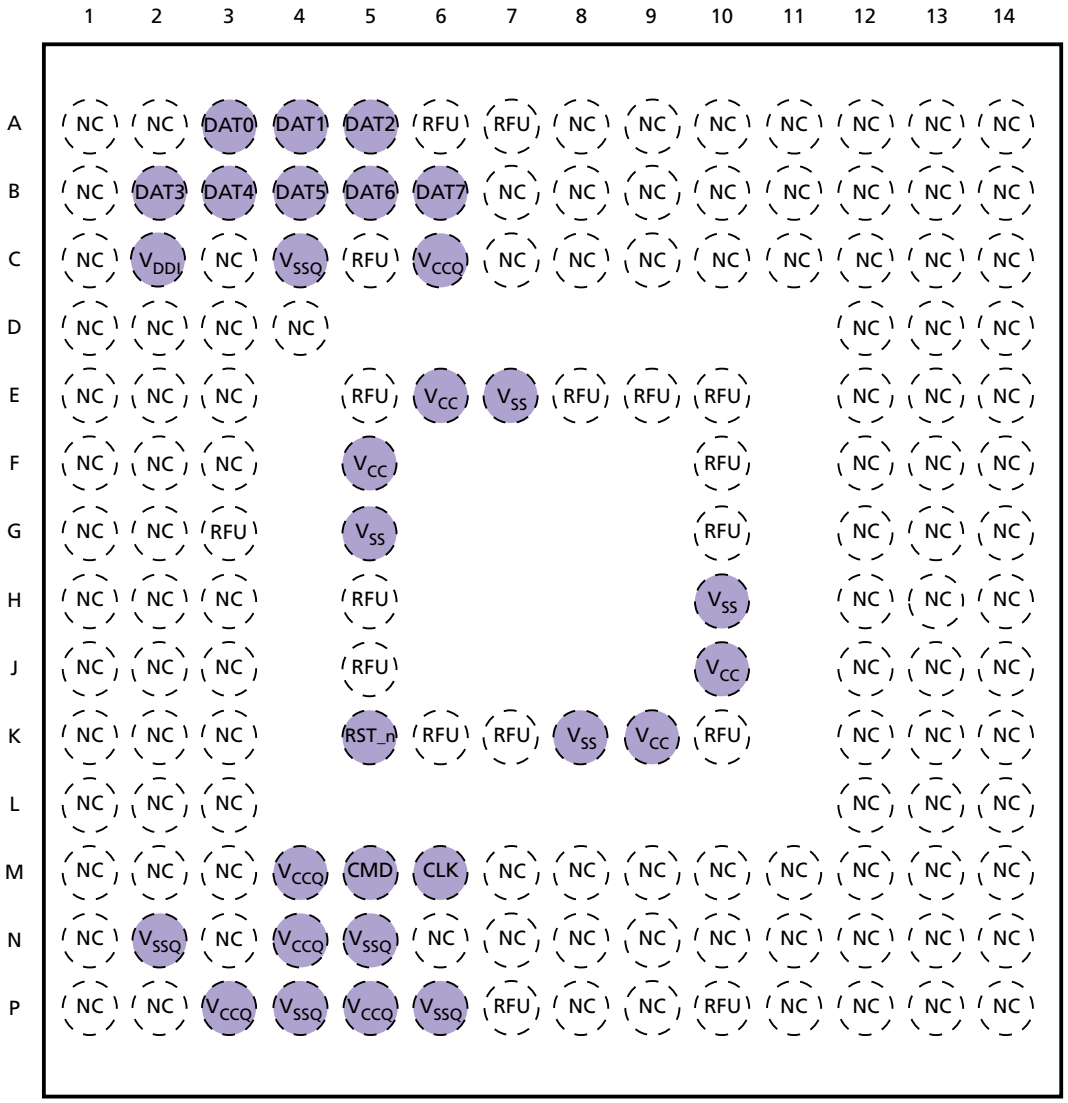
Table 3: Signal Descriptions

Symbol	Type	Description
CLK	Input	Clock: Each cycle of the clock directs a transfer on the command line and on the data line(s). The frequency can vary between the minimum and the maximum clock frequency.
RST_n	Input	Reset: The RST_n signal is used by the host for resetting the device, moving the device to the pre-idle state. By default, the RST_n signal is temporarily disabled in the device. The host must set ECSD register byte 162, bits[1:0] to 0x1 to enable this functionality before the host can use it.
CMD	I/O	Command: This signal is a bidirectional command channel used for command and response transfers. The CMD signal has two bus modes: open-drain mode and push-pull mode (see Operating Modes). Commands are sent from the MMC host to the device, and responses are sent from the device to the host.
DAT[7:0]	I/O	Data I/O: These are bidirectional data signals. The DAT signals operate in push-pull mode. By default, after power-on or assertion of the RST_n signal, only DAT0 is used for data transfer. The MMC controller can configure a wider data bus for data transfer either using DAT[3:0] (4-bit mode) or DAT[7:0] (8-bit mode). *e*·MMC includes internal pull-up resistors for data lines DAT[7:1]. Immediately after entering the 4-bit mode, the device disconnects the internal pull-up resistors on the DAT[3:1] lines. Upon entering the 8-bit mode, the device disconnects the internal pull-ups on the DAT[7:1] lines.
V_{CC}	Supply	V_{CC}: NAND interface (I/F) I/O and NAND Flash power supply.
V_{CCQ}	Supply	V_{CCQ}: *e*·MMC controller core and *e*·MMC I/F I/O power supply.
V_{SS}[1]	Supply	V_{SS}: NAND I/F I/O and NAND Flash ground connection.
V_{SSQ}[1]	Supply	V_{SSQ}: *e*·MMC controller core and *e*·MMC I/F ground connection.
V_{DDI}		Internal voltage node: At least a 0.1µF capacitor is required to connect V_{DDI} to ground. A 1µF capacitor is recommended. Do not tie to supply voltage or ground.
NC	–	No connect: No internal connection is present.
RFU	–	Reserved for future use: No internal connection is present. Leave it floating externally.

Note: 1. V_{SS} and V_{SSQ} are connected internally.

153-Ball Signal Assignments

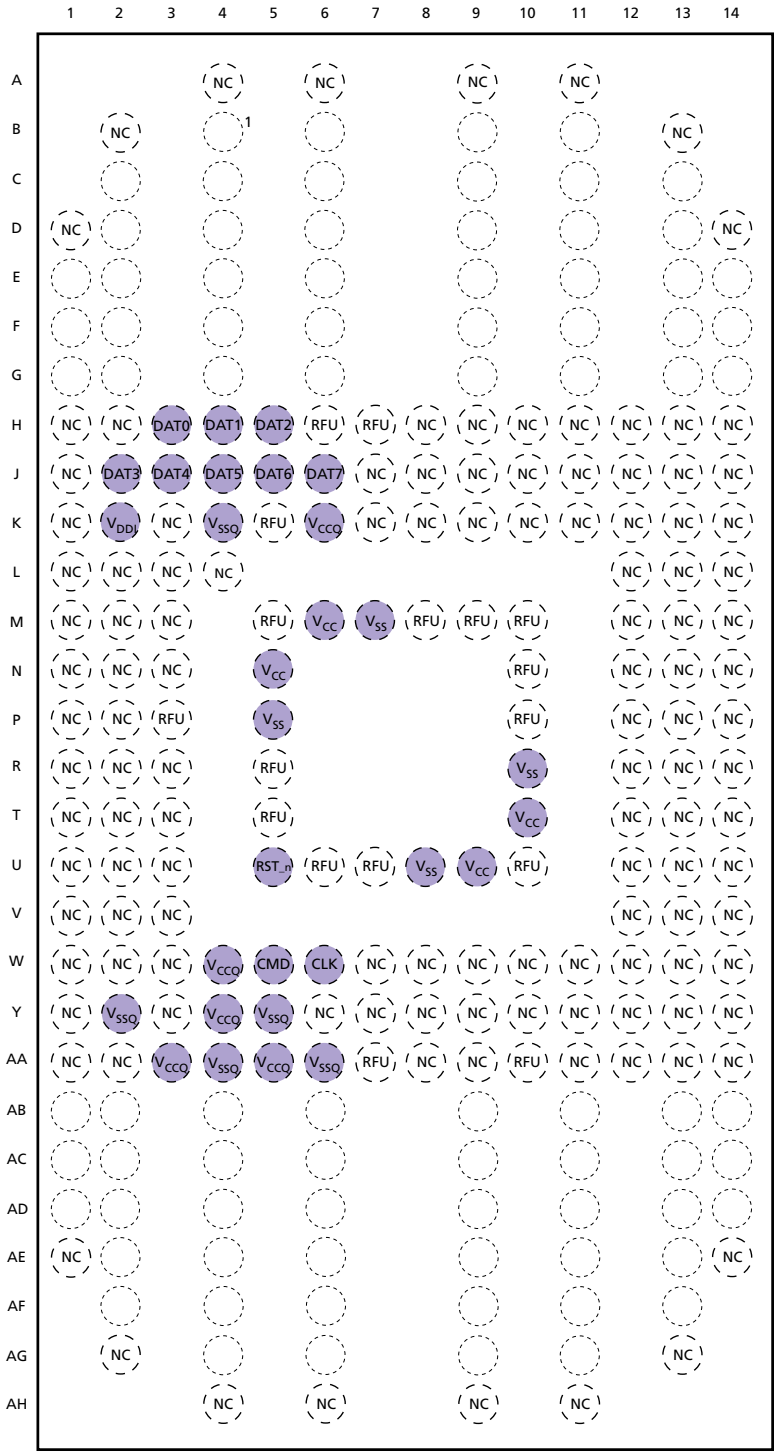
Figure 3: 153-Ball FBGA (top view, ball down)



Notes:
1. Some test pads on the device are not shown. They are not solder balls and are for Micron internal use only.
2. Some previous versions of the JEDEC product or mechanical specification had defined reserved for future use (RFU) balls as no connect (NC) balls. NC balls assigned in the previous specifications could have been connected to ground on the system board. To enable new feature introduction, some of these balls are assigned as RFU in the v4.4 mechanical specification. Any new PCB footprint implementations should use the new ball assignments and leave the RFU balls floating on the system board.

169-Ball Signal Assignments

Figure 4: 169-Ball FBGA (top view, ball down)

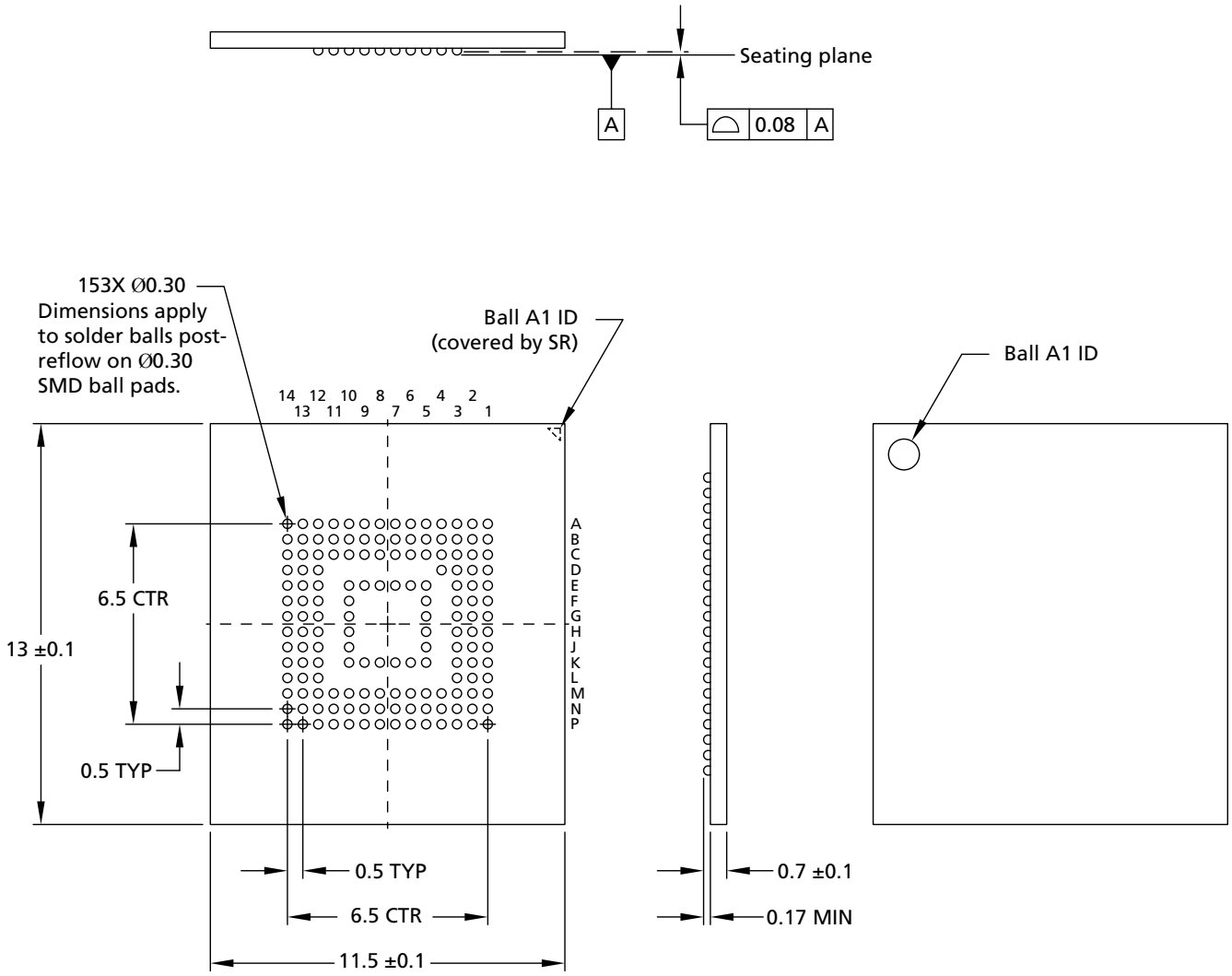


Notes: 1. Empty balls do not denote actual solder balls; they are position indicators only.

2. Some test pads on the device are not shown. They are not solder balls and are for Micron internal use only.
3. Some previous versions of the JEDEC product or mechanical specification had defined reserved for future use (RFU) balls as no connect (NC) balls. NC balls assigned in the previous specifications could have been connected to ground on the system board. To enable new feature introduction, some of these balls are assigned as RFU in the v4.4 mechanical specification. Any new PCB footprint implementations should use the new ball assignments and leave the RFU balls floating on the system board.

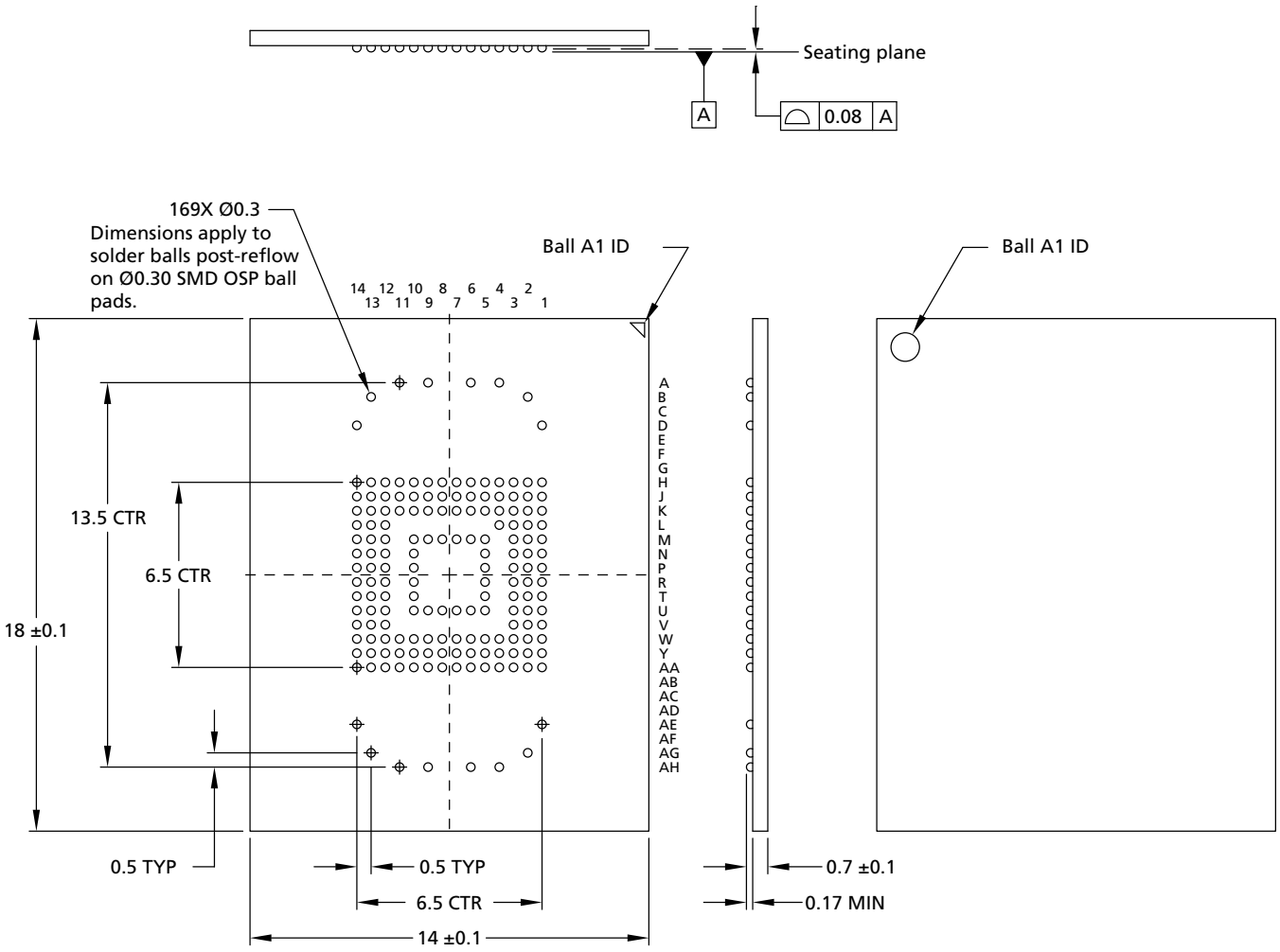
Package Dimensions

Figure 5: 153-Ball WFBGA – 11.5mm x 13.0mm x 0.8mm (Package Code: EA)



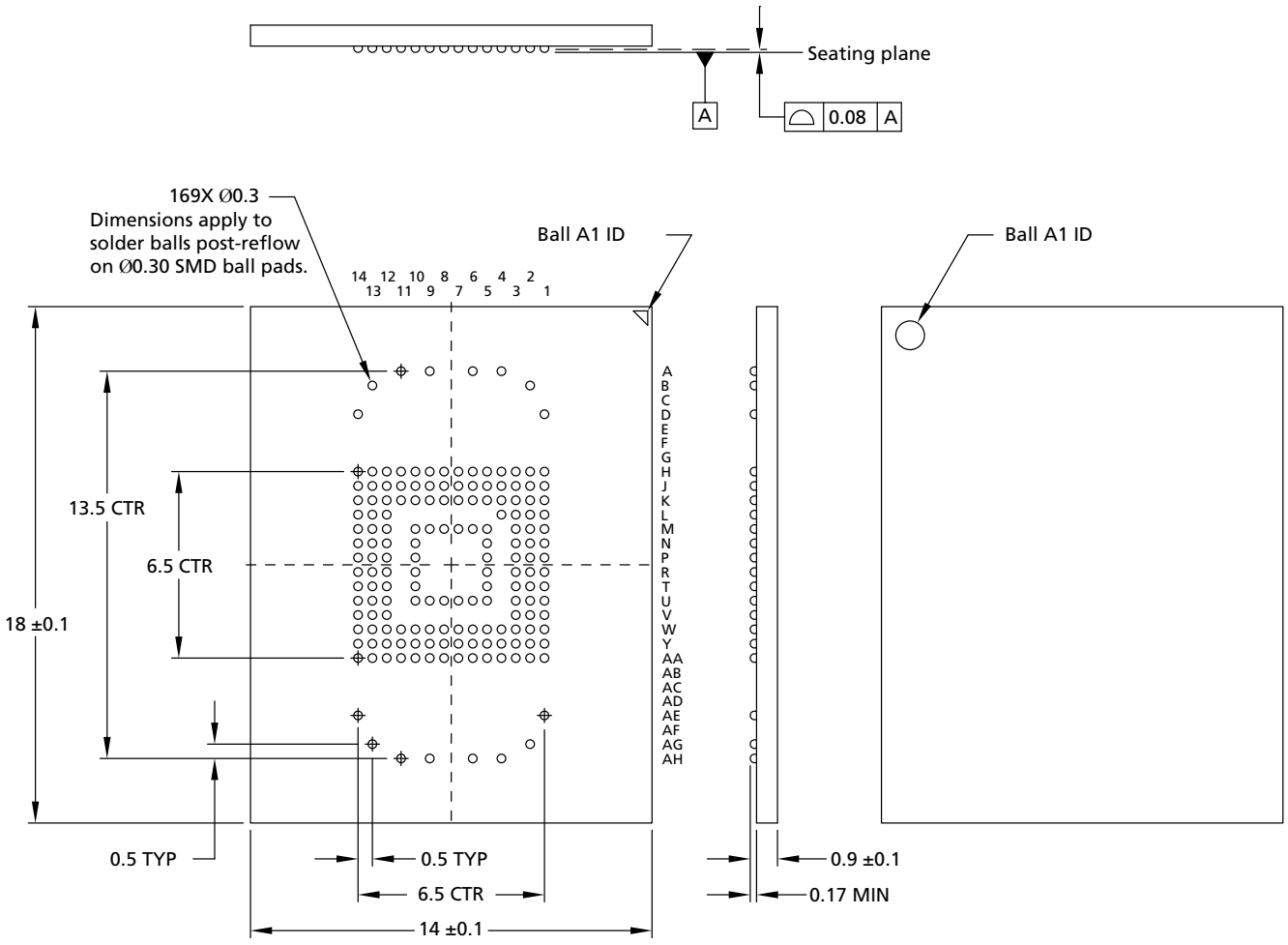
Note: 1. Dimensions are in millimeters.

Figure 6: 169-Ball WFBGA – 14.0mm x 18.00mm x 0.8mm (Package Code: EC)



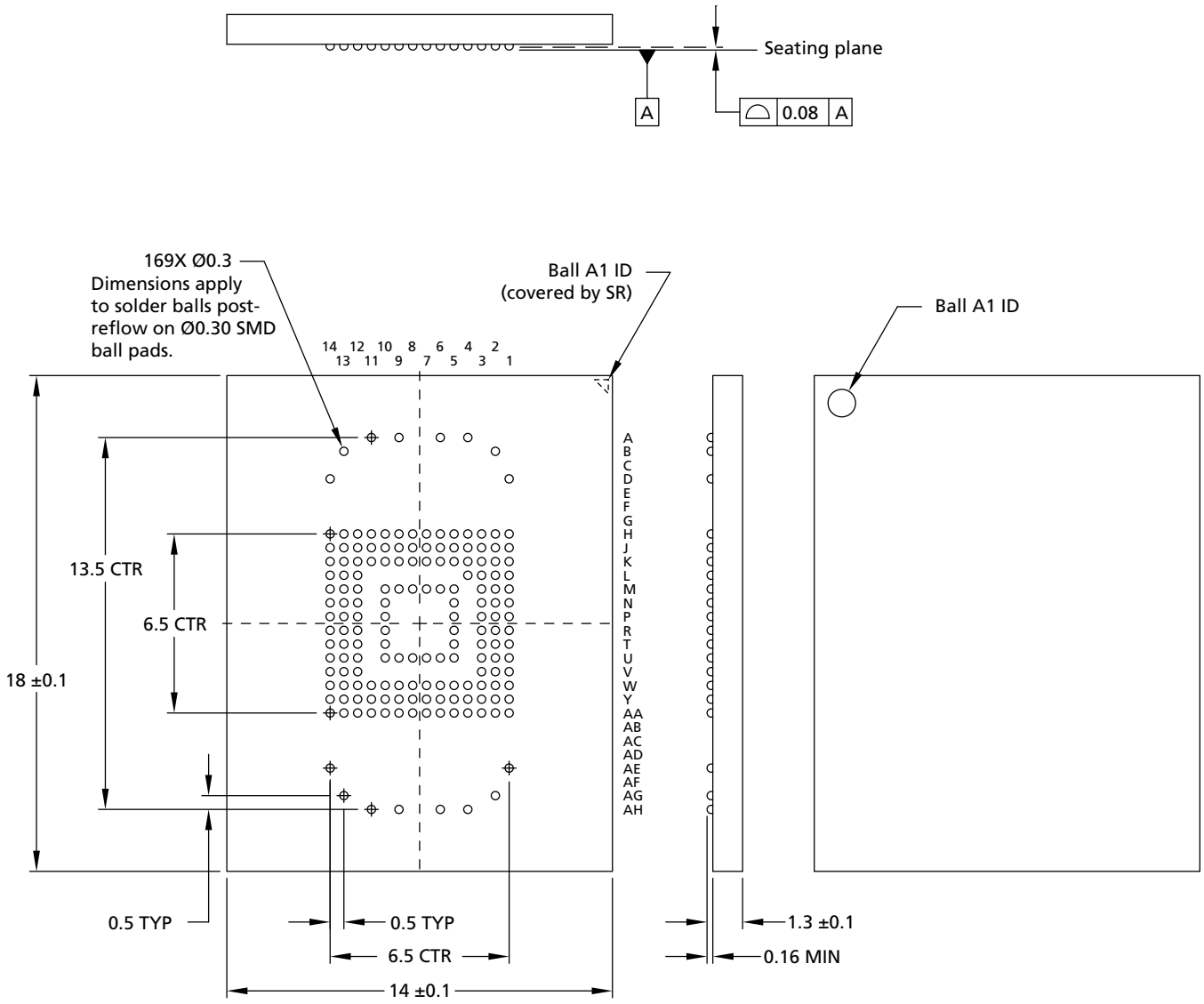
Note: 1. Dimensions are in millimeters.

Figure 7: 169-Ball VFBGA – 14.0mm x 18.00mm x 1.0mm (Package Code: ED)



Note: 1. Dimensions are in millimeters.

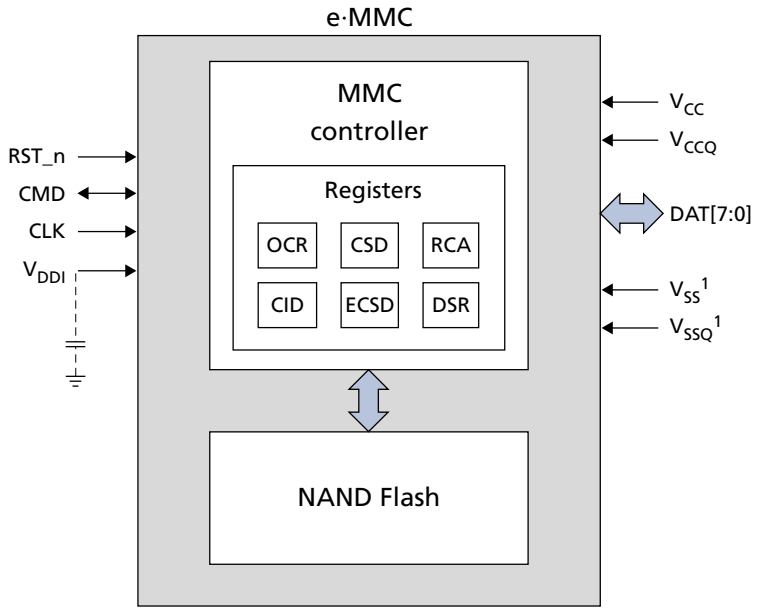
Figure 8: 169-Ball LFBGA – 14.0mm x 18.00mm x 1.4mm (Package Code: DN)



Note: 1. Dimensions are in millimeters.

Architecture

Figure 9: *e*·MMC Functional Block Diagram



Note: 1. V_{SS} and V_{SSQ} are internally connected.

MMC Protocol Independent of NAND Flash Technology

The MMC specification defines the communication protocol between a host and a device. The protocol is independent of the NAND Flash features included in the device. The device has an intelligent on-board controller that manages the MMC communication protocol.

The controller also handles block management functions such as logical block allocation and wear leveling. These management functions require complex algorithms and depend entirely on NAND Flash technology (generation or memory cell type).

The device handles these management functions internally, making them invisible to the host processor.

Defect and Error Management

Micron *e*·MMC incorporates advanced technology for defect and error management. If a defective block is identified, the device completely replaces the defective block with one of the spare blocks. This process is invisible to the host and does not affect data space allocated for the user.

The device also includes a built-in error correction code (ECC) algorithm to ensure that data integrity is maintained.

To make the best use of these advanced technologies and ensure proper data loading and storage over the life of the device, the host must exercise the following precautions:

- Check the status after WRITE, READ, and ERASE operations.
- Avoid power-down during WRITE and ERASE operations.

CID Register

The card identification (CID) register is 128 bits wide. It contains the device identification information used during the card identification phase as required by *e*·MMC protocol. Each device is created with a unique identification number.

Table 4: CID Register Field Parameters

Name	Field	Width	CID Bits	CID Value
Manufacturer ID	MID	8	[127:120]	FEh
Reserved	–	6	[119:114]	–
Card/BGA	CBX	2	[113:112]	01h
OEM/application ID	OID	8	[111:104]	–
Product name	PNM	48	[103:56]	MMC04G MMC08G MMC16G MMC32G MMC64G
Product revision	PRV	8	[55:48]	–
Product serial number	PSN	32	[47:16]	–
Manufacturing date	MDT	8	[15:8]	–
CRC7 checksum	CRC	7	[7:1]	–
Not used; always 1	–	1	0	–

CSD Register

The card-specific data (CSD) register provides information about accessing the device contents. The CSD register defines the data format, error correction type, maximum data access time, and data transfer speed, as well as whether the DS register can be used. The programmable part of the register (entries marked with W or E in the following table) can be changed by the PROGRAM_CSD (CMD27) command.

Table 5: CSD Register Field Parameters

Name	Field		Width	Cell Type[1]	CSD Bits	CSD Value
CSD structure	CSD_STRUCTURE		2	R	[127:126]	03h
System specification version	SPEC_VERS		4	R	[125:122]	4h
Reserved[2]	–		2	TBD	[121:120]	–
Data read access time 1	TAAC		8	R	[119:112]	4Fh
Data read access time 2 in CLK cycles (NSAC × 100)	NSAC		8	R	[111:104]	01h
Maximum bus clock frequency	TRAN_SPEED		8	R	[103:96]	32h
Card command classes	CCC		12	R	[95:84]	0F5h
Maximum read data block length	READ_BL_LEN		4	R	[83:80]	9h
Partial blocks for reads supported	READ_BL_PARTIAL		1	R	79	0h
Write block misalignment	WRITE_BLK_MISALIGN		1	R	78	0h
Read block misalignment	READ_BLK_MISALIGN		77	R	77	0h
DS register implemented	DSR_IMP		1	R	76	1h
Reserved	–		2	R	[75:74]	–
Device size	C_SIZE		12	R	[73:62]	FFFh
Maximum read current at $V_{DD,min}$	VDD_R_CURR_MIN		3	R	[61:59]	7h
Maximum read current at $V_{DD,max}$	VDD_R_CURR_MAX		3	R	[58:56]	7h
Maximum write current at $V_{DD,min}$	VDD_W_CURR_MIN		3	R	[55:53]	7h
Maximum write current at $V_{DD,max}$	VDD_W_CURR_MAX		3	R	[52:50]	7h
Device size multiplier	C_SIZE_MULT		3	R	[49:47]	7h
Erase group size	ERASE_GRP_SIZE		5	R	[46:42]	1Fh
Erase group size multiplier	ERASE_GRP_MULT		5	R	[41:37]	1Fh
Write protect group size	WP_GRP_SIZE	MTFC4GMVEA-4M IT	5	R	[36:32]	07h
		MTFC8GLVEA-4M IT				0Fh
		MTFC16GJVEC-4M IT, MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT				1Fh
Write protect group enable	WP_GRP_ENABLE		1	R	31	1h
Manufacturer default ECC	DEFAULT_ECC		2	R	[30:29]	0h
Write-speed factor	R2W_FACTOR		3	R	[28:26]	2h
Maximum write data block length	WRITE_BL_LEN		4	R	[25:22]	9h
Partial blocks for writes supported	WRITE_BL_PARTIAL		1	R	21	0h

Table 5: CSD Register Field Parameters (Continued)

Name	Field	Width	Cell Type[1]	CSD Bits	CSD Value
Reserved	–	4	R	[20:17]	–
Content protection application	CONTENT_PROT_APP	1	R	16	0h
File-format group	FILE_FORMAT_GRP	1	R/W	15	0h
Copy flag (OTP)	COPY	1	R/W	14	0h
Permanent write protection	PERM_WRITE_PROTECT	1	R/W	13	0h
Temporary write protection	TMP_WRITE_PROTECT	1	R/W/E	12	0h
File format	FILE_FORMAT	2	R/W	[11:10]	0h
ECC	ECC	2	R/W/E	[9:8]	0h
CRC	CRC	7	R/W/E	[7:1]	–
Not used; always 1	–	1	–	0	1h

Notes:
1. R = Read-only

   R/W = One-time programmable and readable

   R/W/E = Multiple writable with value kept after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable

   TBD = To be determined
2. Reserved bits should be read as 0.

ECSD Register

The 512-byte extended card-specific data (ECSD) register defines device properties and selected modes. The most significant 320 bytes are the properties segment. This segment defines device capabilities and cannot be modified by the host. The lower 192 bytes are the modes segment. The modes segment defines the configuration in which the device is working. The host can change the properties of modes segments using the SWITCH command.

Table 6: ECSD Register Field Parameters

Name	Field		Size (Bytes)	Cell Type[1]	ECSD Bytes	ECSD Value
Properties Segment						
Reserved[2]	–		7	–	[511:505]	–
Supported command sets	S_CMD_SET		1	R	504	1h
HPI features	HPI_FEATURES		1	R	503	3h
Background operations support	BKOPS_SUPPORT		1	R	502	1h
Reserved	–		255	–	[501:247]	–
Background operations status	BKOPS_STATUS		1	R	246	0h
Number of correctly programmed sectors	CORRECTLY_PRG_SECTORS_NUM		4	R	[245:242]	–
First initialization time after partitioning (first CMD1 to device ready)	INI_TIMEOUT_PA	MTFC4GMVEA-4M IT	1	R	241	78h
		MTFC8GLVEA-4M IT				F4h
		MTFC16GJVEC-4M IT				F6h
		MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT				FFh
Reserved	–		1	–	240	–
Power class for 52 MHz, DDR at 3.6V[3]	PWR_CL_DDR_52_360		1	R	239	0h
Power class for 52 MHz, DDR at 1.95V[3]	PWR_CL_DDR_52_195		1	R	238	0h
Reserved	–		2	–	[237:236]	–
Minimum write performance for 8-bit at 52 MHz in DDR mode	MIN_PERF_DDR_W_8_52		1	R	235	0h
Minimum read performance for 8-bit at 52 MHz in DDR mode	MIN_PERF_DDR_R_8_52		1	R	234	0h
Reserved	–		1	–	233	–
TRIM multiplier	TRIM_MULT	MTFC4GMVEA-4M IT, MTFC8GLVEA-4M IT	1	R	232	06h
		MTFC16GJVEC-4M IT, MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT				0Fh
Secure feature support	SEC_FEATURE_SUPPORT		1	R	231	15h

Table 6: ECSD Register Field Parameters (Continued)

Name	Field		Size (Bytes)	Cell Type[1]	ECSD Bytes	ECSD Value
SECURE ERASE multiplier	SEC_ERASE_MULT	MTFC4GMVEA-4M IT, MTFC8GLVEA-4M IT	1	R	230	02h
		MTFC16GJVEC-4M IT, MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT				06h
SECURE TRIM multiplier	SEC_TRIM_MULT	MTFC4GMVEA-4M IT, MTFC8GLVEA-4M IT	1	R	229	03h
		MTFC16GJVEC-4M IT, MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT				09h
Boot information	BOOT_INFO		1	R	228	7h
Reserved	–		1	–	227	–
Boot partition size	BOOT_SIZE_MULT		1	R	226	80h
Access size	ACC_SIZE	MTFC4GMVEA-4M IT, MTFC8GLVEA-4M IT	1	R	225	06h
		MTFC16GJVEC-4M IT, MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT				07h
High-capacity erase unit size	HC_ERASE_GRP_SIZE	MTFC4GMVEA-4M IT, MTFC8GLVEA-4M IT	1	R	224	08h
		MTFC16GJVEC-4M IT, MTFC32GJVED-4M IT, MTFC64GJVDN-4M IT				10h
High-capacity erase timeout	ERASE_TIMEOUT_MULT		1	R	223	01h
Reliable write-sector count	REL_WR_SEC_C		1	R	222	01h
High-capacity write protect group size	HC_WP_GRP_SIZE	MTFC4GMVEA-4M IT	1	R	221	01h
		MTFC8GLVEA-4M IT, MTFC16GJVEC-4M IT				02h
		MTFC32GJVED-4M IT				04h
		MTFC64GJVDN-4M IT				08h
Sleep current (V_{CC})	S_C_VCC		1	R	220	08h
Sleep current (V_{CCQ})	S_C_VCCQ		1	R	219	08h
Reserved	–		1	–	218	–
Sleep/awake timeout	S_A_TIMEOUT		1	R	217	10h
Reserved	–		1	–	216	–
Sector count	SEC_COUNT	MTFC4GMVEA-4M IT	4	R	[215:212]	0070C000h
		MTFC8GLVEA-4M IT				00E88000h
		MTFC16GJVEC-4M IT				01D30000h
		MTFC32GJVED-4M IT				03B20000h
		MTFC64GJVDN-4M IT				07700000h

Table 6: ECSD Register Field Parameters (Continued)

Name	Field	Size (Bytes)	Cell Type[1]	ECSD Bytes	ECSD Value
Reserved	–	1	–	211	–
Minimum write performance for 8-bit at 52 MHz	MIN_PERF_W_8_52	1	R	210	08h
Minimum read performance for 8-bit at 52 MHz	MIN_PERF_R_8_52	1	R	209	08h
Minimum write performance for 8-bit at 26 MHz and 4-bit at 52 MHz	MIN_PERF_W_8_26_4_52	1	R	208	08h
Minimum read performance for 8-bit at 26 MHz and 4-bit at 52 MHz	MIN_PERF_R_8_26_4_52	1	R	207	08h
Minimum write performance for 4-bit at 26 MHz	MIN_PERF_W_4_26	1	R	206	08h
Minimum read performance for 4-bit at 26 MHz	MIN_PERF_R_4_26	1	R	205	08h
Reserved	–	1	–	204	–
Power class for 26 MHz at 3.6V[3]	PWR_CL_26_360	1	R	203	00h
Power class for 52 MHz at 3.6V[3]	PWR_CL_52_360	1	R	202	00h
Power class for 26 MHz at 1.95V[3]	PWR_CL_26_195	1	R	201	00h
Power class for 52 MHz at 1.95V[3]	PWR_CL_52_195	1	R	200	00h
Partition switching timing	PARTITION_SWITCH_TIME	1	R	199	1h
Out-of-interrupt busy timing	OUT_OF_INTERRUPT_TIME	1	R	198	02h
Reserved	–	1	–	197	–
Card type	CARD_TYPE	1	R	196	07h
Reserved	–	1	–	195	–
CSD structure version	CSD_STRUCTURE	1	R	194	2h
Reserved	–	1	–	193	–
Extended CSD revision	EXT_CSD_REV	1	R	192	5h
Modes Segment					
Command set	CMD_SET	1	R/W/E_P	191	0h
Reserved	–	1	–	190	–
Command set revision	CMD_SET_REV	1	R	189	0h
Reserved	–	1	–	188	–
Power class	POWER_CLASS	1	R/W/E_P	187	0h
Reserved	–	1	–	186	–
High-speed interface timing	HS_TIMING	1	R/W/E_P	185	0h
Reserved	–	1	–	184	–

Table 6: ECSD Register Field Parameters (Continued)

Name	Field	Size (Bytes)	Cell Type[1]	ECSD Bytes	ECSD Value
Bus width mode	BUS_WIDTH	1	W/E_P	183	0h
Reserved	–	1	–	182	–
Erased memory content	ERASED_MEM_CONT	1	R	181	0h
Reserved	–	1	–	180	–
Partition configuration	PARTITION_CONFIG	1	R/W/E, R/W/E_P	179	0h
Boot configuration protection	BOOT_CONFIG_PROT	1	R/W, R/W/C_P	178	0h
Boot bus width	BOOT_BUS_WIDTH	1	R/W/E	177	0h
Reserved	–	1	–	176	–
High-density erase group definition	ERASE_GROUP_DEF	1	R/W/E_P	175	00h
Reserved	–	1	–	174	–
Boot area write protection register	BOOT_WP	1	R/W, R/W/C_P	173	0h
Reserved	–	1	–	172	–
User write protection register	USER_WP	1	R/W, R/W/C_P, R/W/E_P	171	0h
Reserved	–	1	–	170	–
Firmware configuration	FW_CONFIG	1	R/W	169	0h
RPMB size	RPMB_SIZE_MULT	1	R	168	1h
Write reliability setting register[3]	WR_REL_SET	1	R/W	167	00h[4]
Write reliability parameter register	WR_REL_PARAM	1	R	166	05h
Reserved	–	1	–	165	–
Manually start background operations	BKOPS_START	1	W/E_P	164	–
Enable background operations handshake	BKOPS_EN	1	R/W	163	0h
Hardware reset function	RST_n_FUNCTION	1	R/W	162	0h
HPI management	HPI_MGMT	1	R/W/E_P	161	0h
Partitioning support	PARTITIONING_SUPPORT	1	R	160	3h

Table 6: ECSD Register Field Parameters (Continued)

Name	Field		Size (Bytes)	Cell Type[1]	ECSD Bytes	ECSD Value
Maximum enhanced area size	MAX_ENH_SIZE_MULT	MTFC4GMVEA-4M IT	3	R	[159:157]	0001C3h
		MTFC8GLVEA-4M IT				0001D1h
		MTFC16GJVEC-4M IT				0001D3h
		MTFC32GJVED-4M IT				0001D9h
		MTFC64GJVDN-4M IT				0001DCh
Partitions attribute	PARTITIONS_ATTRIBUTE		1	R/W	156	0h
Partitioning setting	PARTITION_SETTING_COMPLETED		1	R/W	155	0h
General-purpose partition size	GP_SIZE_MULT		12	R/W	[154:143]	0h
Enhanced user data area size	ENH_SIZE_MULT		3	R/W	[142:140]	0h
Enhanced user data start address	ENH_START_ADDR		4	R/W	[139:136]	0h
Reserved	–		1	–	135	–
Bad block management mode	SEC_BAD_BLK_MGMNT		1	R/W	134	0h
Reserved	–		134	–	[133:0]	–

Notes:
1. R = Read-only

   R/W = One-time programmable and readable

   R/W/E = Multiple writable with the value kept after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable

   R/W/C_P = Writable after the value is cleared by a power cycle and assertion of the RST_n signal (the value not cleared by CMD0 reset) and readable

   R/W/E_P = Multiple writable with the value reset after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable

   W/E_P = Multiple writable with the value reset after power cycle, assertion of the RST_n signal, and any CMD0 reset, and not readable

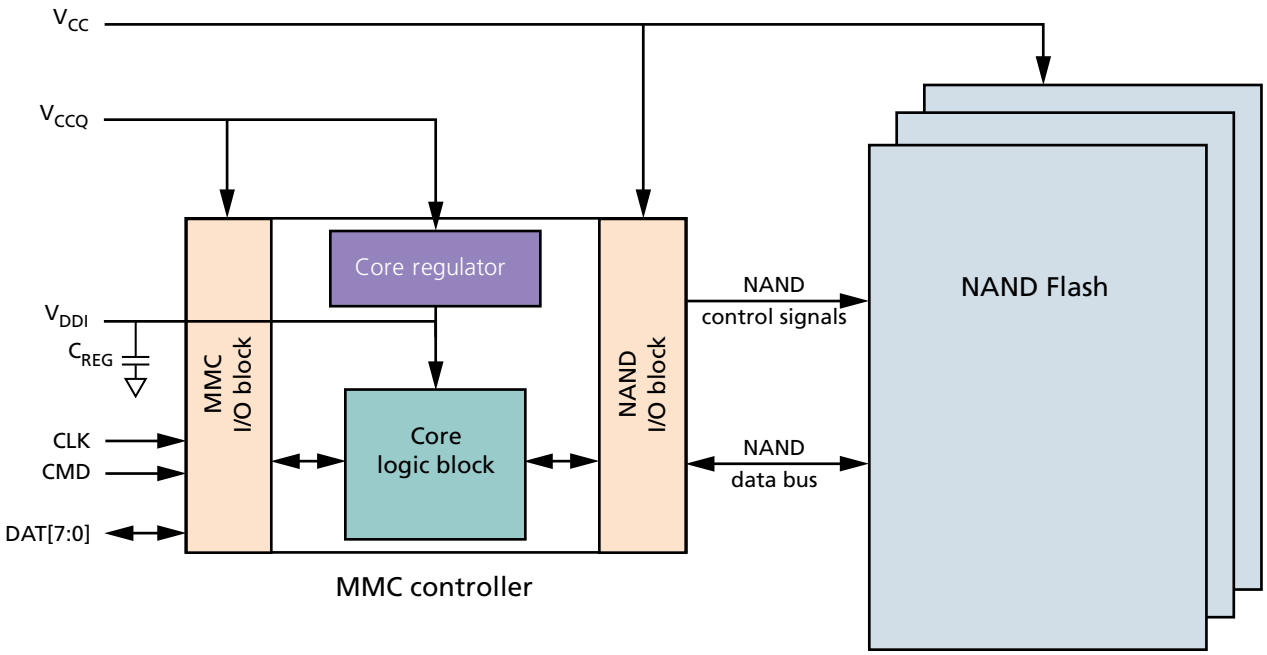
   TBD = To be determined
2. Reserved bits should be read as 0.
3. Micron has tested power failure under best application knowledge conditions with positive results. Customers may request a dedicated test for their specific application condition.
4. Set at 00h when shipped for optimized write performance; can be set to 1Fh to enable protection on previously written data if power failure occurs during a WRITE operation. This byte is one-time programmable.

DC Electrical Specifications – Device Power

The device current consumption for various device configurations is defined in the power class fields of the ECSD register.

V_{CC} is used for the NAND Flash device and its interface voltage; V_{CCQ} is used for the controller and the *e*·MMC interface voltage. A C_{REG} capacitor must be connected to the V_{DDI} terminal to stabilize regulator output on the system.

Figure 10: Device Power Diagram



Note: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not guaranteed. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

Table 7: Absolute Maximum Ratings

Parameters	Symbol	Min	Max	Unit
Voltage input	V_{IN}	–0.6	4.6	V
V_{CC} supply	V_{CC}	–0.6	4.6	V
V_{CCQ} supply	V_{CCQ}	–0.6	4.6	V
Storage temperature	T_{STG}	–40	85	°C

Note: 1. Voltage on any pin relative to V_{SS}.

Table 8: Operating Conditions

Parameters	Symbol	Min	Typ	Max	Unit
Supply voltage (controller and I/O)	V_{CCQ}	1.65	–	1.95	V
		2.70	–	3.6	
Supply voltage (NAND)	V_{CC}	2.70	–	3.6	V
Supply power-on for 3.3V	^{t}PRUH	–	–	35	ms
Supply power-on for 1.8V	^{t}PRUL	–	–	25	ms
V_{DDI} capacitance value	C_{REG}[1]	0.1	–	–	µF
Operating temperature	T_A	–40	–	85	°C

Note: 1. C_{REG} is used to stabilize the internal regulator output to controller core logic voltages. Micron recommends using the following capacitor values:
C_{VCC} (capacitor for V_{CC}) = 4.3µF.
C_{VCCQ} (capacitor for V_{CCQ}) = 4.3µF
C_{REG} = 1.0µF.

Revision History

Rev. D – 07/12

- Updated MMC-Specific Features
- Updated Ordering Information table
- Added Part Numbering information
- Updated 169-ball LFBGA package dimension drawing (package code DN)
- Corrected typographical error in ECSD Register table and updated note 4

Rev. C – 05/12

- Updated CSD Register and ECSD Register
- Corrected Ordering Information
- To Production status

Rev. B – 02/12

- Changed the part numbers and the minimum operating temperature from -25 to -40 degrees C

Rev. A – 01/12

- Initial release